Ministry of Supply - D.L.R.D./S.R.D.E.

VALVE ELECTRONIC CV4094

Specification MOS/CV4094
Issue 1 Dated 8.1.59
To be read in conjunction with K.1001, BS448 and
BS1409

SECURITY

Specification
Unclassified

Valve
Unclassified

Indicates a change

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Type of Valve - Reliable R.F. Beam Tetrodo Cut Off Cathode - Directly Heated Envelope - Glass Metallised Prototype - VI9186	Sharp		See K1001/4 walve shall the CV No. 1	only	t that the	d with
RATING (All limiting values are absolute) Filament Voltage (V)	1.25	note	See App. 1 BS 448/B5G/	BAS to CV2		
Filament Current (mA) Max. Anode Voltage (V) Max. Screen Voltage (V)	100 100 100		CONNECTIONS			
Max. Cathode Current (mA) Max. Bulb Temperature (°C) Max. Shock (Short Duration) (g)	7•0 100 450		PIN ELECT			<u>s</u>
Max. Acceleration (Continuous Operation) (g)	5	2	1 a (red dot) 2 g ₂ 3 f (-), bp ₁ , u 4 g ₁ 5 f (+), bp ₂			
Typical Operating Conditions Measured at Va = Vg ₂ = 45V·Vg ₄ = 0 Rg ₁ = 2 MΩ Anode Current Screen Current (mA)	3.0 0.9 2.0		DIMENSIONS See BS448/B5G/F Size Reference No. 1 See App. 1 to CV2237			
Mutual Conductance (mA/V)			Dimension (millimet		Min.	Max.
Capacitances (pF) Cin (nom.) Cout (nom.) Ca, g ₁ (max.)	4.0 4.0 0.01		A. Overall Length - 38. Diameter B. Minor - 7.2 C. Major - 9.8 Lead Length 38.1			
		2	MOU	NTING AN	POSITION Y	

To be performed in addition to those applicable in K.1001. Tests shall be performed in the specified order unless otherwise agreed with the inspecting Authority.

Test conditions - unless otherwise specified								
K. 1001 Test		Test Conditions	AQL	Insp.	Sym- bol	Limits		Units
Ref.	1650	1650 00110110115	1 %	% Level		Min.	Max.	
7•1	Glass Strain	No Voltages	6.5	I				
	Electrode Insulation Reverse Grid Current Contact Potential	$Vf = 0$ $Vg_{1} - all = -100V$ $Vg_{2} - all = -100V$ $Va - all = -100V$ $Rg_{1} = 500 \text{ k}\Omega \text{ max.}$ $Va' = Vg_{2} = 55V$ $Vg_{1} = -1.0V$ $Vf = 1.25V$ $Va = Vg_{2} = 0$ $Rg_{1} = 200 \text{ k}\Omega$		100% 100% 100%	R R R Ig ₁	100 100 100 -	0•5	ΩΜΩ ΩΜΩ ΩΜΩ Αμ
	GROUP B Filament Current Anode Current Screen Grid Current Mutual Conductance (1)	Combined AQL	1.0 0.65 0.65 0.65	11 11 11 11	If Ia Is ₂	88 1•9 0•5 1•5	122 4•1 1•3 2•5	mA mA mA
	GROUP C Mutual Conductance (2) Mutual Conductance (3) TEST Anode Resistance R.F. Noise	Combined AQL Vf = 1.0V Vf = 1.0V Take reading after 15 mins. Esig = 30 mVrms Ref. K.1006 (4.10.3.1)	6.5 2.5 2.5 2.5 2.5	I I I	gm. gm. gm.	1.2	2•5	mA/V mA/V M∂/√ MΩ

CV 4094/1/2

		A					<u> </u>	
K.1001	Test	Test conditions	AQL %	Insp. Level	Sym- bol	Limits		Units
Ref.						Min.	Max.	
5•12	GROUP D Lead Fragility		6.5	IA				
5	Filament Anode Short	Note 1		T. A.				
v	Capacitances	Measured on a 1Mc/s bridge with the valve mounted in a fully screened socket. No shield.	6•5	IC	Ca,g ₁ Cin Cout	3	0•01 5 5	pf pf pf
	Functional Test			T.A.		opera	y in W	shall isfac- .S. A40
	GROUP E							İ
11.3	Fatigue	Acceleration = 5g peak min. Time = 99 hours Note 2		IA				
	Post Fatigue Tests	Combined AQL	4.0					
	R.F. Noise Mutual Conductance (1)	As in Group C	2•5		gm	1.2		mA/V
11•4	Shock	No voltages. Hammer Angle 30°		IA				
-	Post Shock	Combined AQL	4.0					
	Tests R.F. Noise	As in Group C	2.5					
	Mutual Conductance (1)	n - 2	2•5		gm	1•2		mA/V
A VI/5	GROUP F	Rg ₁ = 5 MΩ	A					
A VI/ 5•1	Stability Life Test		330					
	Mutual Conductance (2)	Vf = 1.0V	1.0	I	gm	1.2		mA/V
		1					CV 4	094/1/

K. 1001	Test	Test Conditions	AQL %	Insp.	Sym-		~w	Units
Ref.	1050	1000 0034110100	%	Level	bol	Min.	Max.	
A VI/ 5•3	GROUP F (Cont'd) Intermittent Life Test	7						
	Life Test End Point (500 hrs.)	Combined AQL	6.5	IA		= *		
A VI/ 5.6	Inoperatives		2.5			-		
J.0	Mutual Conductance (1)	191	2•5		gm	1•2		mA/V
	Electrode Insulation	Vf = 0 Vg ₁ - all = -100V Vg ₂ - all = -100V Va - all = -100V	4.0		R R R	50 50 50		ΜΩ ΜΩ
	End Point (1,000hrs.)	Combined AQL	10	IA				
A VI/ 5.6	Inoperatives		4.0					
	Mutual Conductance (1)		4.0		gm	1.2		mA/V
	Reverse Grid	As in Group A	4.0		Ig ₁	-	1.0	μА
-	Contact Potential	$Vf = 1.25V$ $Va = Vg_2 = 0$ $Rg_1 = 200k\Omega$	4.0		Ig ₁	To be		
	Electrode Insulation	Vf = 0 Vg ₁ - all = -100V Vg ₂ - all = -100V Va - all = -100V	6•5		R R R	30 30 30		ΜΩ ΜΩ
	GROUP G							12.
A IX/ 2.4 and 2.5	Electrical retest after 28 days hold- ing period			100%				=
A VI/ 5.6	Inoperatives Mutual Conductance (1)	, we	0.5		gm	1•5	2•5	mA/V
		As in Group A	0.5		Ig ₁	-	0.5	μА

CV 4094/1/4

- 1. Raise Vf until filament opens. Test for filament to anode short only. After performance of the filament burn out test, if the short circuit shall pass in excess of five times the rated filament current without burning out the short circuit, the valve shall be deemed a failure. This test shall be performed by a Service Laboratory on three valves which shall be in addition to the required number for Type Approval samples. Manufacturers' data are not required for this test.
- 2. Filament voltage and H.T. voltage switched simultaneously 1 min. on and 3 min. off throughout duration of test. Frequency = 170 cps. The valves to be vibrated in each of three mutually perpendicular planes in turn for periods of 30, 30 and 39 hours. One plane to include the longitudinal axis of the valve.

ELECTRONIC VALVE SPECIFICATIONS SPECIFICATION MOS/CV4094 ISSUE NO.1 DATED 8.1.59. AMENDMENT NO.2 On Page 4, under GROUP F (Cont'd) Intermittent Life Test End Point (500 hours)	(2) Immediately following the above, in column headed "Test"	Amend Life Test to read Life Test End Point (1,000 hours) (500 hours)	August, 1959	N.71076/D
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SPECIFICATION CV .4094 ISSUE 1 DATED 8.1.59

AMENDMENT No. 1

Page 2 GROUP C

Immediately following the test for "Mutual Conductance (3)"

Add new test as follows: -

<u>Add</u>	new	test	as rollows:	_					- 1 K
			Test	AQL	Insp.	Sym-	Limi	<u>ts</u>	0/1
Test			Conditions		Level		Min.	Max•	Units
Mutual Conducta	nce	(4)	Vf = 0.8V	2.5	I	gm	1.1	-	mA/V

April, 1959. N.54788/D. T.V.C. for S.R.D.E.

ELECTRONIC VALVE SPECIFICATION

CV-4094 Issue 1 Dated 8-1-59

AMENDMENT NO. 3

Page 1 Base

Delete:- See Appendix 1 to CV.2237

Dimensions

Delete: - See Appendix 1 to CV.2237

Signals Radio Development Establishment

JANUARY, 1962. (8533)